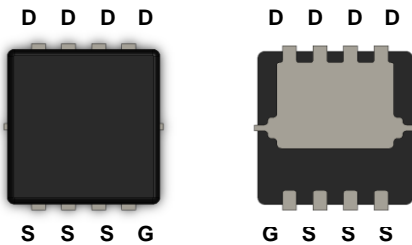


General Description

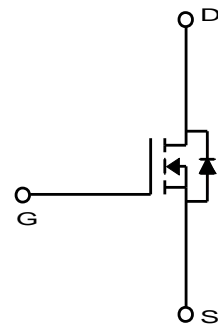
The MDV1522 uses advanced Magnachip’s MOSFET Technology, which provides high performance in on-state resistance, fast switching performance and excellent quality. MDV1522 is suitable for DC/DC converter and general purpose applications.

Features

- $V_{DS} = 30V$
- $I_D = 34A @ V_{GS} = 10V$
- $R_{DS(ON)} < 4.9m\Omega @ V_{GS} = 10V$
- $< 6.8m\Omega @ V_{GS} = 4.5V$
- 100% UIL Tested
- 100% Rg Tested



PDFN33



Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-Source Voltage		V_{DSS}	30	V
Gate-Source Voltage		V_{GSS}	±20	V
Continuous Drain Current ⁽¹⁾	$T_C=25^\circ C$ (Package limited)	I_D	34.0	A
	$T_C=25^\circ C$ (Silicon limited)		59.2	
	$T_C=70^\circ C$		47.6	
	$T_A=25^\circ C$		19.9 ⁽³⁾	
	$T_A=70^\circ C$		16.0 ⁽³⁾	
Pulsed Drain Current		I_{DM}	136	A
Power Dissipation	$T_C=25^\circ C$	P_D	27.7	W
	$T_C=70^\circ C$		17.7	
	$T_A=25^\circ C$		3.4 ⁽³⁾	
	$T_A=70^\circ C$		2.2 ⁽³⁾	
Single Pulse Avalanche Energy ⁽²⁾		E_{AS}	136	mJ
Junction and Storage Temperature Range		T_J, T_{stg}	-55~150	°C

Thermal Characteristics

Characteristics	Symbol	Rating	Unit
Thermal Resistance, Junction-to-Ambient ⁽¹⁾	$R_{\theta JA}$	36	°C/W
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	4.5	

Ordering Information

Part Number	Temp. Range	Package	Packing	Quantity	RoHS Status
MDV1522URH	-55~150°C	PowerDFN33	Tape & Reel	5000 units	Halogen Free

Electrical Characteristics (T_J = 25°C)

Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	I _D = 250μA, V _{GS} = 0V	30	-	-	V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	1.3	1.9	2.7	
Drain Cut-Off Current	I _{DSS}	V _{DS} = 30V, V _{GS} = 0V T _J =55°C	-	-	1 5	μA
Gate Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V	-	-	±0.1	
Drain-Source ON Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 16A T _J =125°C	-	4.3 6.2	4.9 7.1	mΩ
		V _{GS} = 4.5V, I _D = 13A	-	5.7	6.8	
Forward Transconductance	g _{fs}	V _{DS} = 5V, I _D = 16A	-	-	-	S
Dynamic Characteristics						
Total Gate Charge	Q _{g(10V)}	V _{DS} = 15.0V, I _D = 16A, V _{GS} = 10V	20.5	29.4	38.2	nC
Total Gate Charge	Q _{g(4.5V)}		10.0	14.3	18.6	
Gate-Source Charge	Q _{gs}		-	5.6	-	
Gate-Drain Charge	Q _{gd}		-	4.7	-	
Input Capacitance	C _{iss}	V _{DS} = 15.0V, V _{GS} = 0V, f = 1.0MHz	1295	1850	2404	pF
Reverse Transfer Capacitance	C _{rss}		131	188	244	
Output Capacitance	C _{oss}		260	372	483	
Turn-On Delay Time	t _{d(on)}	V _{GS} = 10V, V _{DS} = 15.0V, I _D = 16A, R _G = 3.0Ω	-	10.5	-	ns
Rise Time	t _r		-	11.3	-	
Turn-Off Delay Time	t _{d(off)}		-	38.2	-	
Fall Time	t _f		-	10.0	-	
Gate Resistance	R _g	f=1 MHz	0.5	0.95	3.0	Ω
Drain-Source Body Diode Characteristics						
Source-Drain Diode Forward Voltage	V _{SD}	I _S = 16A, V _{GS} = 0V	-	0.80	1.1	V
Body Diode Reverse Recovery Time	t _{rr}	I _F = 16A, di/dt = 100A/μs	-	29.3	44.0	ns
Body Diode Reverse Recovery Charge	Q _{rr}		-	20.3	30.4	nC

Note :

- Surface mounted FR-4 board by JEDEC (jesd51-7)
- E_{AS} is tested at starting T_J = 25°C, L = 0.1mH, I_{AS} = 30.4A, V_{DD} = 27V, V_{GS} = 10V.
- T < 10sec.

Characteristic Graph

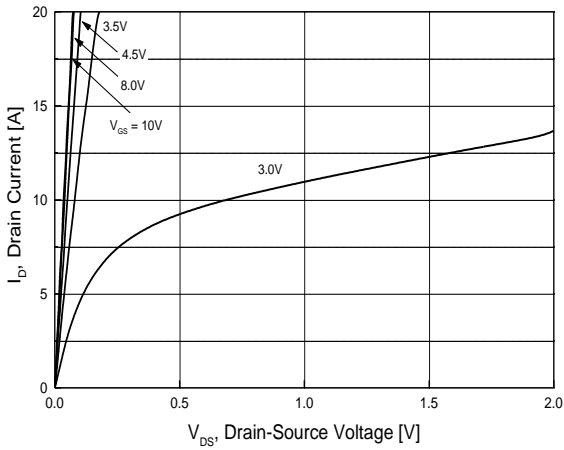


Fig.1 On-Region Characteristics

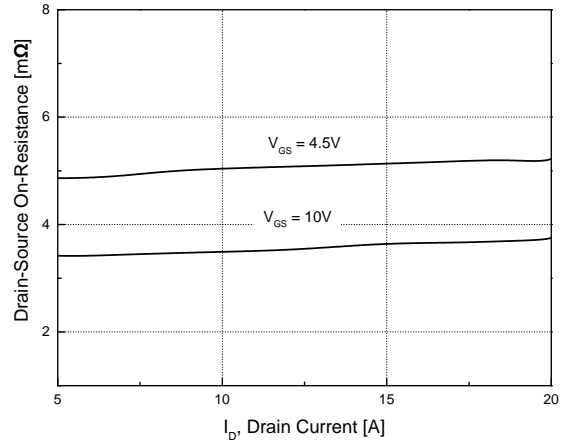


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

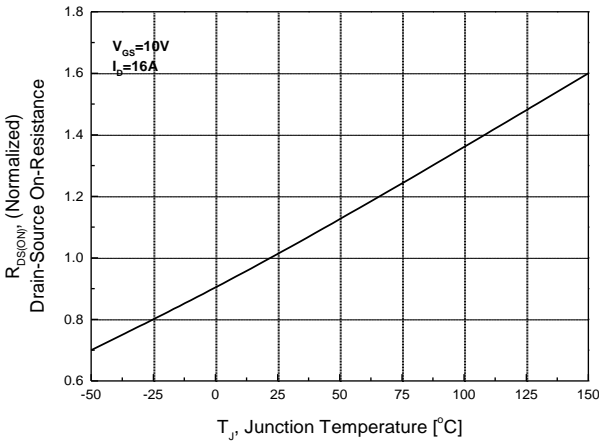


Fig.3 On-Resistance Variation with Temperature

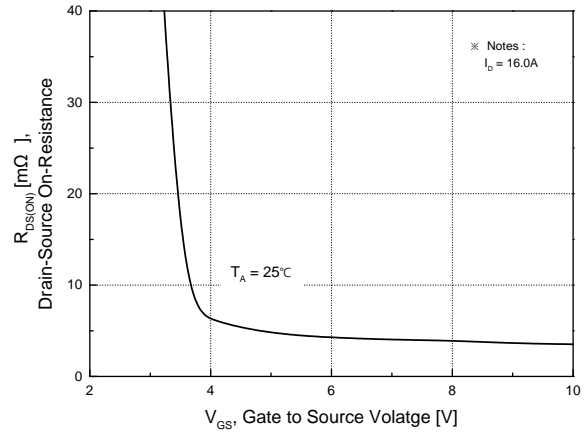


Fig.4 On-Resistance Variation with Gate to Source Voltage

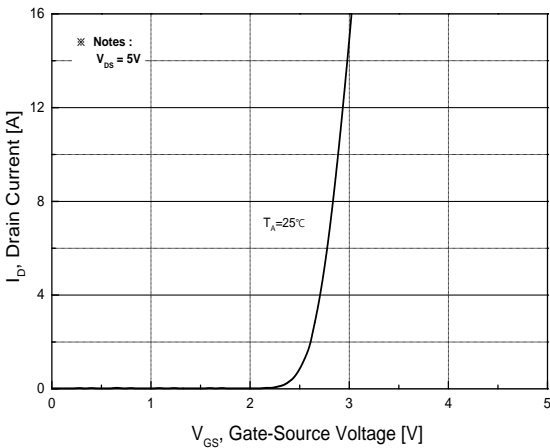


Fig.5 Transfer Characteristics

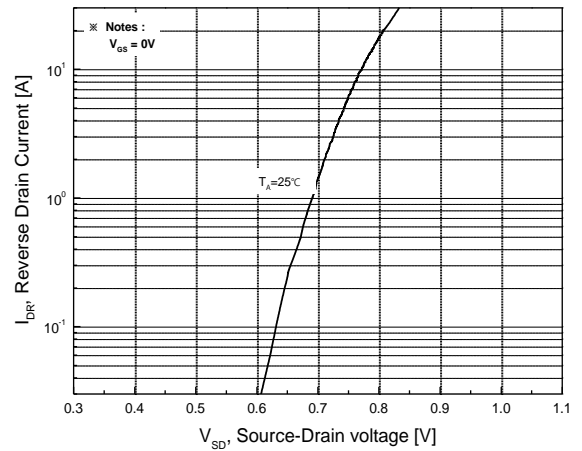


Fig.6 Body Diode Forward Voltage Variation with Source Current and Temperature

Characteristic Graph

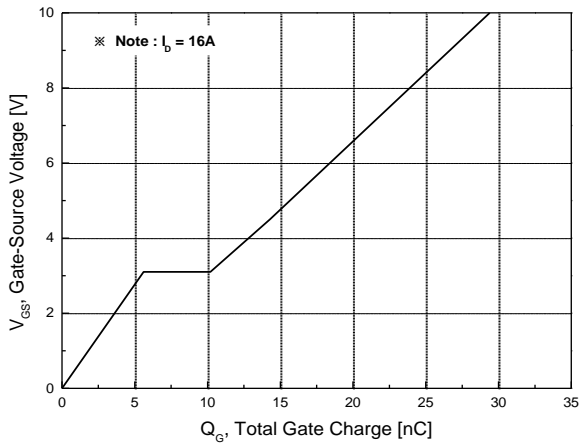


Fig.7 Gate Charge Characteristics

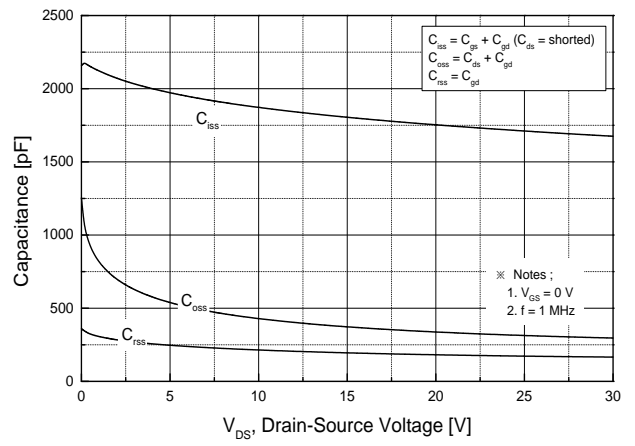


Fig.8 Capacitance Characteristics

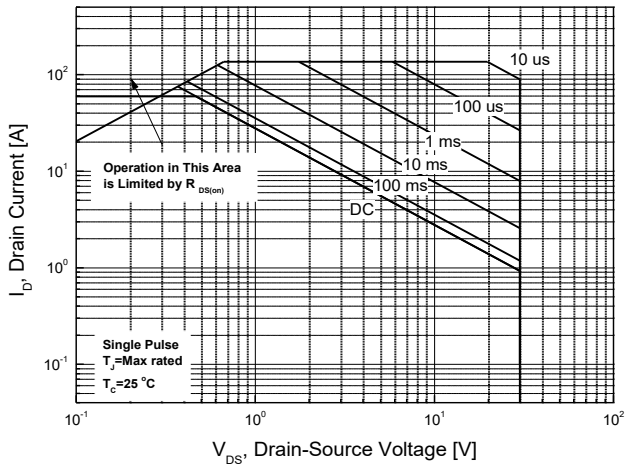


Fig.9 Maximum Safe Operating Area

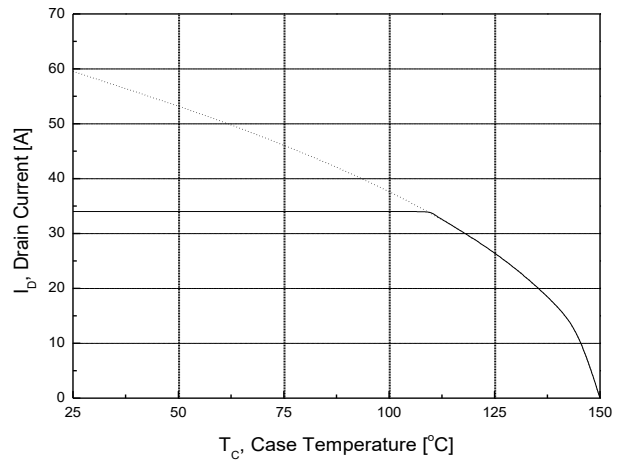


Fig.10 Maximum Drain Current vs. Case Temperature

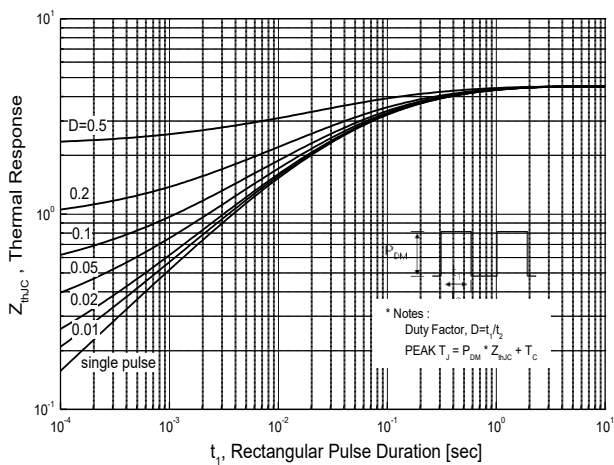
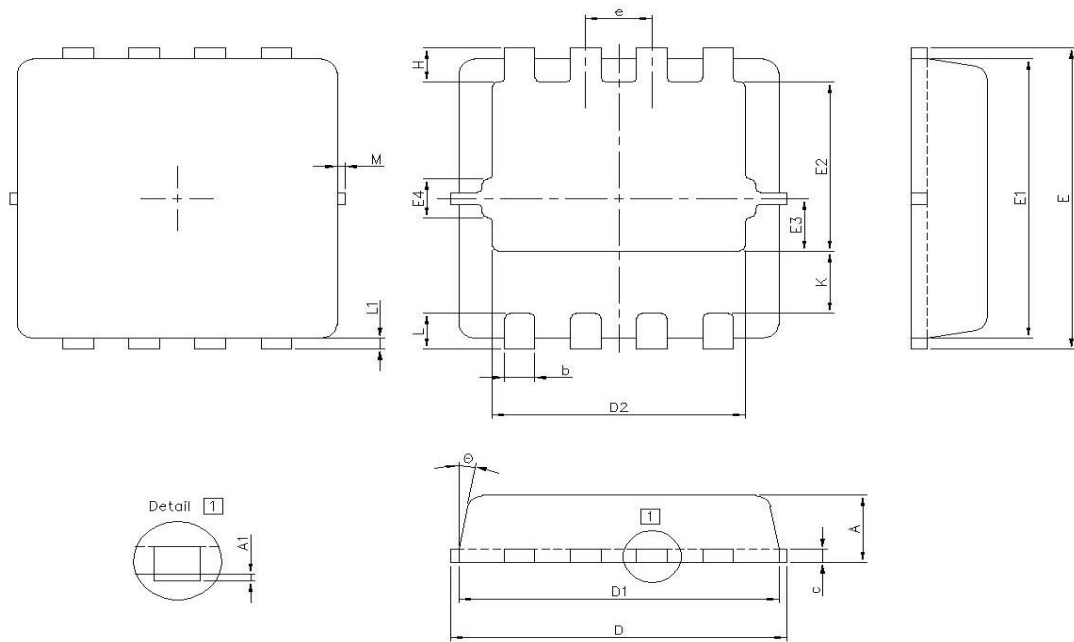


Fig.11 Transient Thermal Response Curve

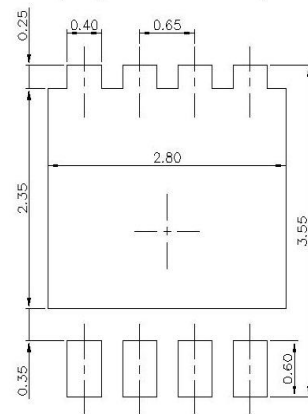
Package Dimension

PowerDFN33 (3.3x3.3mm)

Dimensions are in millimeters, unless otherwise specified



Land Pattern
(Only for Reference)




(Unit: mm)

DIM	Min	Max	DIM	Min	Max
A	0.70	0.80	E2	1.78	1.98
A1	0.00	0.05	E3	0.49	0.69
b	0.25	0.35	E4	0.35 TYP.	
c	0.10	0.25	e	0.65 BSC	
D	3.20	3.40	K	0.70 TYP.	
D1	3.00	3.20	L	0.30	0.50
D2	2.39	2.59	L1	0.13 TYP.	
E	3.25	3.45	H	0.27	0.47
E1	3.00	3.20	Ø	0	12

[Note] PKG size do not include Mold flash , Protrusions, Gate burrs

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